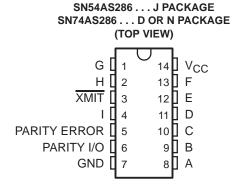
- Generate Either Odd or Even Parity for Nine Data Lines
- Cascadable for n-Bit Parity
- Direct Bus Connection for Parity Generation or Checking by Using the Parity I/O Port
- Glitch-Free Bus During Power Up/Down
- Package Options Include Plastic Small-Outline (D) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs

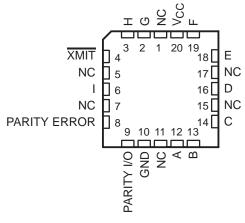
#### description

The SN54AS286 and SN74AS286 universal 9-bit parity generators/checkers feature a local output for parity checking and a 48-mA bus-driving parity input/output (I/O) port for parity generation/checking. The word-length capability is easily expanded by cascading.

The transmit (XMIT) control input is implemented specifically to accommodate cascading. When XMIT is low, the parity tree is disabled and PARITY ERROR remains at a high logic level regardless of the input levels. When XMIT is high, the parity tree is enabled. PARITY ERROR indicates a parity error when either an even number of inputs (A–I) are high and PARITY I/O is forced to a low logic level, or when an odd number of inputs are high and PARITY I/O is forced to a high logic level.



SN54AS286...FK PACKAGE (TOP VIEW)



NC - No internal connection

The I/O control circuitry was designed so that the I/O port remains in the high-impedance state during power up or power down to prevent bus glitches.

The SN54AS286 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to  $125^{\circ}$ C. The SN74AS286 is characterized for operation from  $0^{\circ}$ C to  $70^{\circ}$ C.

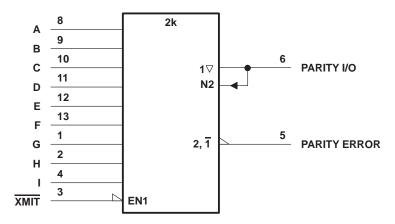
#### **FUNCTION TABLE**

NUMBER OF INPUTS (A-I) THAT ARE HIGH	XMIT	PARITY I/O	PARITY ERROR
0, 2, 4, 6, 8	I	Н	Н
1, 3, 5, 7, 9	1	L	Н
0.0400	h	h	Н
0, 2, 4, 6, 8	h	I	L
12570	h	h	L
1, 3, 5, 7, 9	h	I	Н

h = high input level H = high output level I = low input level L = low output level

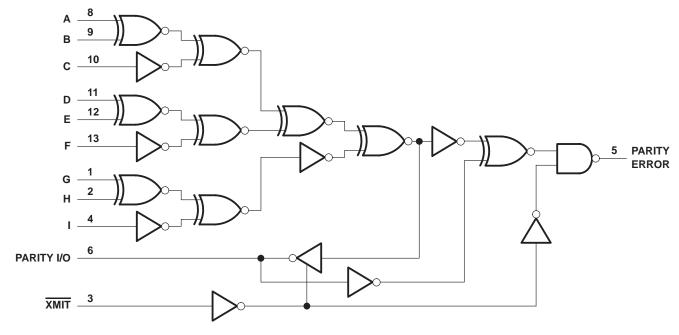
TEXAS INSTRUMENTS

# logic symbol†



 $<sup>^\</sup>dagger$  This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, J, and N packages.

# logic diagram (positive logic)



Pin numbers shown are for the D, J, and N packages.



### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V <sub>CC</sub>	
Input voltage, V <sub>I</sub>	
Voltage applied to a disabled 3-state output	
Operating free-air temperature range, T <sub>A</sub> : SN54AS286	–55°C to 125°C
SN74AS286	0°C to 70°C
Storage temperature range	-65°C to 150°C

#### recommended operating conditions

			SI	SN54AS286			SN74AS286		
			MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage		4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage		2			2			V
VIL	Low-level input voltage				0.8			8.0	V
	I Pale I and and an annual	PARITY ERROR			-2			-2	4
ІОН	High-level output current	PARITY I/O			-12			-15	mA
		PARITY ERROR			20			20	
IOL	Low-level output current	PARITY I/O			32			48	mA
TA	Operating free-air temperature		-55		125	0		70	°C

# electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

				SN	54AS28	36	SN				
	PARAMETER	TEST CONDITIONS			TYP‡	MAX	MIN	TYP‡	MAX	UNIT	
VIK		$V_{CC} = 4.5 \text{ V},$	I <sub>I</sub> = -18 mA			-1.2			-1.2	V	
	All outputs	$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V},$	$I_{OH} = -2 \text{ mA}$	V <sub>CC</sub> -2	1		V <sub>CC</sub> -2				
VOH			$I_{OH} = -3 \text{ mA}$	2.4	2.9		2.4	3		.,	
	PARITY I/O	V <sub>CC</sub> = 4.5 V	$I_{OH} = -12 \text{ mA}$	2.4						V	
			$I_{OH} = -15 \text{ mA}$				2.4				
VoL	PARITY ERROR		I <sub>OL</sub> = 20 mA		0.35	0.5		0.35	0.5	V	
	PARITY I/O	V <sub>CC</sub> = 4.5 V	I <sub>OL</sub> = 32 mA			0.5					
			$I_{OL} = 48 \text{ mA}$						0.5		
	PARITY I/O		V <sub>I</sub> = 5.5 V			0.1			0.1	A	
l <sub>l</sub>	All other inputs	V <sub>CC</sub> = 5.5 V	V <sub>I</sub> = 7 V			0.1			0.1	mA	
	PARITY I/O§	, , , , , , , , , , , , , , , , , , ,				50			50		
<sup>I</sup> IH	All other inputs	$V_{CC} = 5.5 \text{ V},$	$V_{  } = 2.7 \text{ V}$			20			20	μΑ	
	PARITY I/O§	V 55V	V 0.4V			-0.5			-0.5	A	
ΊL	All other inputs	V <sub>CC</sub> = 5.5 V,	$V_{I} = 0.4 V$		-0.5				-0.5	mA	
IOI		V <sub>CC</sub> = 5.5 V,	V <sub>O</sub> = 2.25 V	-30		-112	-30		-112	mA	
loo	Transmit	V-0-55V			30	43		30	43	mA	
Icc	Receive	V <sub>CC</sub> = 5.5 V			35	50		35	50	шА	

<sup>‡</sup> All typical values are at  $V_{CC} = 5 \text{ V}$ ,  $T_A = 25^{\circ}\text{C}$ .

The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, IOS.



<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

<sup>§</sup> For I/O ports, the parameters I<sub>IH</sub> and I<sub>IL</sub> include the off-state output current.

# SN54AS286, SN74AS286 9-BIT PARITY GENERATORS/CHECKERS WITH BUS-DRIVER PARITY I/O PORT SDAS050B - DECEMBER 1983 - REVISED DECEMBER 1994

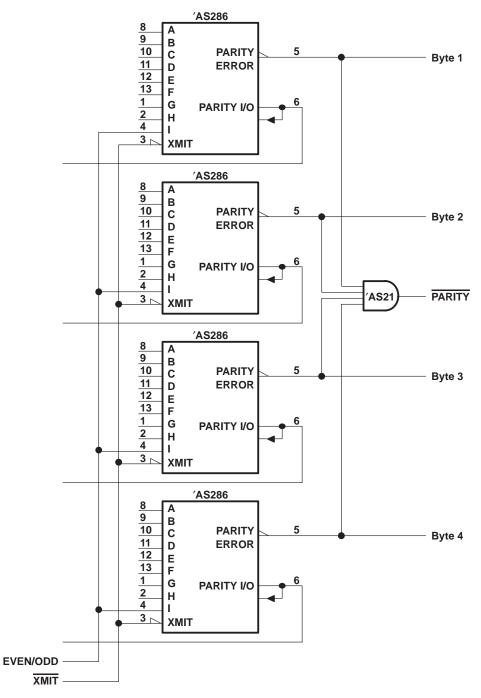
# switching characteristics (see Figure 3)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	C <sub>L</sub> R1 R2 T <sub>A</sub>	$V_{CC} = 4.5 ^{\circ}$ $C_{L} = 50 \text{ pF}$ $R1 = 500 \Omega$ $R2 = 500 \Omega$ $T_{A} = \text{MIN to}$ $SN54AS286$		V, AS286	UNIT	
			MIN	MAX	MIN	MAX		
t <sub>PLH</sub>	Λ Λ Ι	DADITY I/O	3	17	3	15		
t <sub>PHL</sub>	Any A – I	PARITY I/O	3	15	3	14	ns	
t <sub>PLH</sub>	Λ Λ Ι	DADITY EDDOD	3 20	3	16.5			
t <sub>PHL</sub>	Any A – I	PARITY ERROR	3	18	3	16.5	ns	
t <sub>PLH</sub>	DA DITY I/O	DADITY EDDOD	3	10	3			
t <sub>PHL</sub>	PARITY I/O	PARITY ERROR	3	10	3	9	ns	
<sup>t</sup> PZH	VA 41-	DARITYLIG	3	14	3	13		
tPZL	XMIT	PARITY I/O	3	17	3	16	ns	
<sup>t</sup> PHZ	XMIT	PARITY I/O	3	13	3	11.5	ne	
t <sub>PLZ</sub>	AIVII I	PARTITI/O	3	11	3	10	10 ns	

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

#### **APPLICATION INFORMATION**

Figure 1 shows a 32-bit parity generator/checker with output polarity switching, parity-error detection, and parity on every byte.



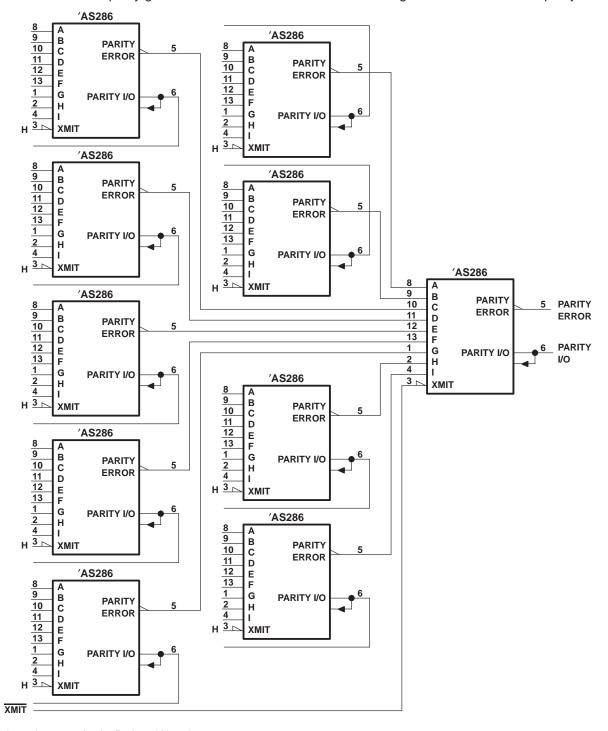
Pin numbers shown are for the D, J, and N packages.

Figure 1. 32-Bit Parity Generator/Checker



#### **APPLICATION INFORMATION**

Figure 2 shows a 90-bit parity generator/checker with XMIT on the last stage available for use with parity detection.

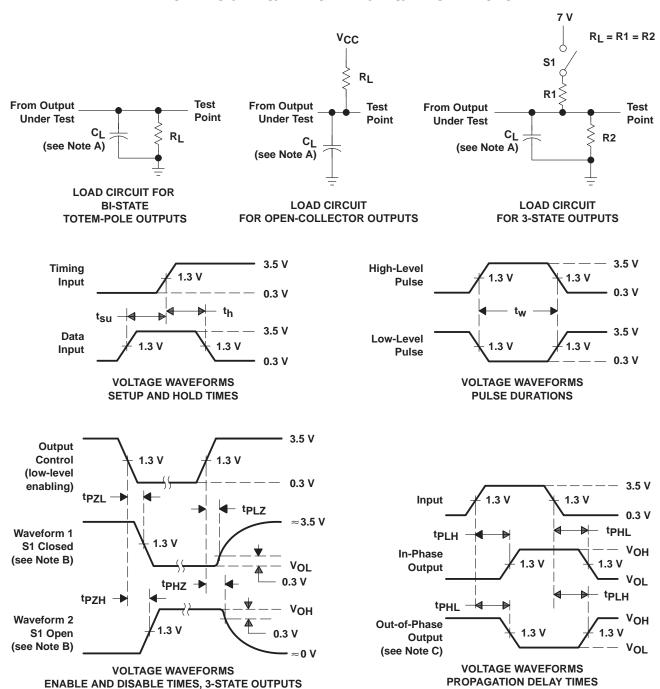


Pin numbers shown are for the D, J, and N packages.

Figure 2. 90-Bit Parity Generator/Checker With Parity-Error Detection



#### PARAMETER MEASUREMENT INFORMATION SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



NOTES: A. C<sub>I</sub> includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
- All input pulses have the following characteristics: PRR  $\leq$  1 MHz,  $t_r = t_f = 2$  ns, duty cycle = 50%.
- The outputs are measured one at a time with one transition per measurement.

Figure 3. Load Circuits and Voltage Waveforms



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#### PACKAGING INFORMATION

Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
							(6)				
SN74AS286D	ACTIVE	SOIC	D	14	50	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	0 to 70	AS286	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# **PACKAGE MATERIALS INFORMATION**

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#### **TUBE**



#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN74AS286D	D	SOIC	14	50	506.6	8	3940	4.32



SMALL OUTLINE INTEGRATED CIRCUIT



#### NOTES:

- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm, per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
- 5. Reference JEDEC registration MS-012, variation AB.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE INTEGRATED CIRCUIT



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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